N-channel TrenchMOS logic level FET Rev. 03 — 8 June 2010

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant

sources Suitable for thermally demanding environments due to 175 °C rating

1.3 Applications

- 12 V and 24 V loads
- Automotive systems

General purpose power switching

Suitable for logic level gate drive

Motors, lamps and solenoids

1.4 Quick reference data

Table 1.	Quick reference data	

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	55	V
I _D	drain current	V _{GS} = 5 V; T _{mb} = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>	<u>[1]</u>	-	-	75	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	300	W
Static cha	racteristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 12</u>		-	3.5	4.2	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C		-	3.1	3.7	mΩ



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Table 1.	Quick reference da	tacontinued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Avalanch	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 75 \text{ A}; V_{sup} \leq 55 \text{ V}; \\ R_{GS} &= 50 \Omega; V_{GS} = 5 \text{ V}; \\ T_{j(\text{init})} &= 25 ^\circ\text{C}; \text{ unclamped} \end{split}$	-	-	1.2	J
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$\label{eq:VGS} \begin{array}{l} V_{GS} = 5 \; V; \; I_D = 25 \; A; \\ V_{DS} = 44 \; V; \; T_j = 25 \; ^\circ C; \\ \text{see } \underline{Figure 13} \end{array}$	-	37	-	nC

[1] Continuous current is limited by package.

2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2		drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S

SOT78 (TO-220AB)

3. Ordering information

Table 3. O	rdering	information
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Type number	Package		
	Name	Description	Version
BUK954R2-55B	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Тур	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	55	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	-	55	V
V _{GS}	gate-source voltage			-15	-	15	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 5 V; see <u>Figure 3</u> ; see <u>Figure 1</u>	<u>[1]</u>	-	-	191	A
		$T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V};$ see Figure 1; see Figure 3	[2]	-	-	75	А
		T_{mb} = 100 °C; V_{GS} = 5 V; see <u>Figure 1</u>	[2]	-	-	75	А
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \ \mu$ s; pulsed; see <u>Figure 3</u>		-	-	765	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	-	300	W
T _{stg}	storage temperature			-55	-	175	°C
Tj	junction temperature			-55	-	175	°C
Source-drain	n diode						
Is	source current	T _{mb} = 25 °C	[2]	-	-	75	А
			[3]	-	-	191	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	-	765	А
Avalanche ru	uggedness						
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D = 75 \text{ A}; \ V_{sup} \leq 55 \text{ V}; \ R_{GS} = 50 \ \Omega; \\ V_{GS} = 5 \text{ V}; \ T_{j(\text{init})} = 25 \ ^\circ\text{C}; \ \text{unclamped} \end{split}$		-	-	1.2	J

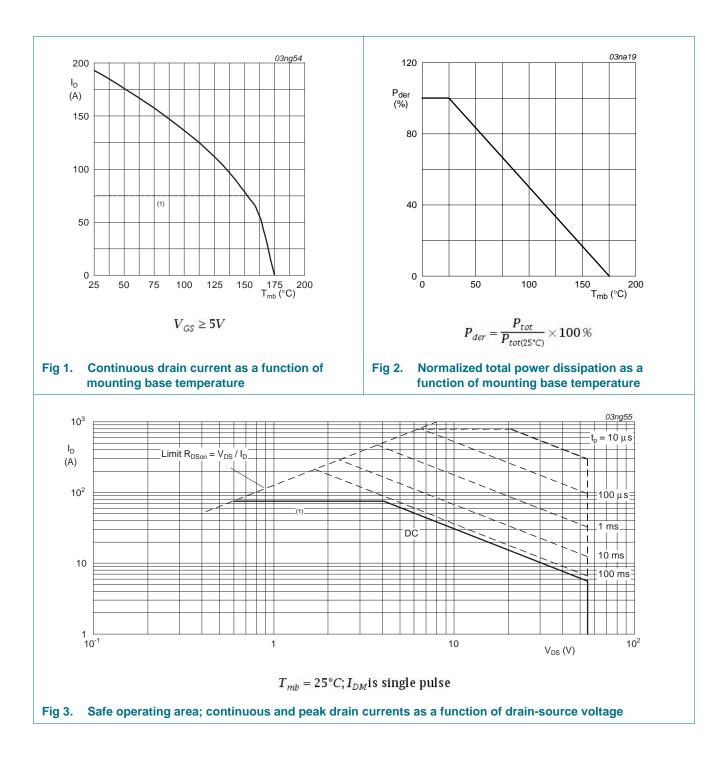
[1] Current is limited by power dissipation chip rating.

[2] Continuous current is limited by package.

[3] Current is limited by power dissipation chip rating.

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5. Thermal characteristics

mbol	Par	ameter	Condition	S		Min	Тур	Max	Unit
h(j-mb)	fron	mal resistance n junction to unting base	see Figure	<u>9 4</u>		-	-	0.5	K/W
h(j-a)	thermal resistance from junction to ambient		vertical ir	n still air		-	60	-	K/W
								03ng56	
1									
Z _{th(j-mb)}	δ = 0.5						-		
(K/W)									
10 ⁻¹	0.2								
10	0.1								
	0.05								
				+ + + + + + + + - + - + - + - + - + - +					
10 ⁻²	0.02					P		$\delta = \frac{t_p}{T}$	
	single	shot					┦─└──	J_L_ ₿	
							► t _p	t	
10 ⁻³	0 ⁻⁶	10 ⁻⁵	10 ⁻⁴	10 ⁻³	10 ⁻²	10 ⁻¹			
1	0	10	10	10	10	10	t _p (s)	I	

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6. Characteristics

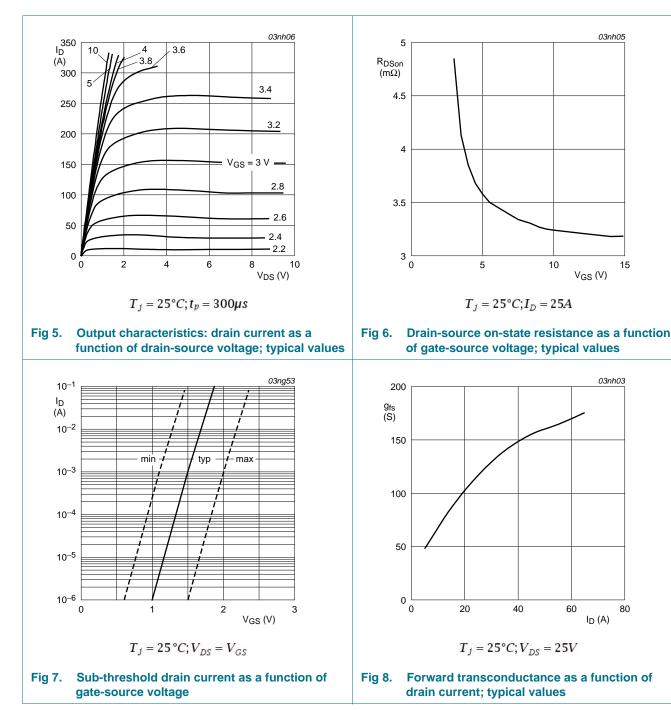
Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS} drain-source		$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; see <u>Figure 10</u>	1.1	1.5	2	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 10</u>	-	-	2.3	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; see <u>Figure 10</u>	0.5	-	-	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
I _{GSS}	gate leakage current	V _{DS} = 0 V; V _{GS} = 15 V; T _j = 25 °C	-	2	100	nA
		$V_{DS} = 0 \text{ V}; \text{ V}_{GS} = -15 \text{ V}; \text{ T}_{j} = 25 \text{ °C}$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 5 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	3.5	4.2	mΩ
		V _{GS} 4.5 V; I _D = 25 A; T _j = 25 °C	-	-	4.4	mΩ
		V _{GS} = 5 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 11</u> ; see <u>Figure 12</u>	-	-	8.4	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C	-	3.1	3.7	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	e charge $I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	95	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 13</u>	-	17	-	nC
Q _{GD}	gate-drain charge		-	37	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	7665	10220	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 14</u>	-	1044	1253	pF
C _{rss}	reverse transfer capacitance		-	466	638	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 5 \text{ V};$	-	63	-	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; \ T_j = 25 \ ^{\circ}C$	-	232	-	ns
t _{d(off)}	turn-off delay time		-	273	-	ns
t _f	fall time		-	178	-	ns
L _D	internal drain inductance	from contact screw on mounting base to centre of die ; $T_j = 25 \text{ °C}$	-	3.5	-	nH
		from drain lead 6 mm from package to centre of die ; $T_j = 25 \text{ °C}$	-	4.5	-	nH
L _S	internal source inductance	from source lead to source bond pad ; $T_j = 25 \text{ °C}$	-	7.5	-	nH

Source-drain diode

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Table 6.	Characteristics continued					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{SD}	source-drain voltage	$I_S = 40 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 15</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s};$	-	78	-	ns
Qr	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	171	-	nC

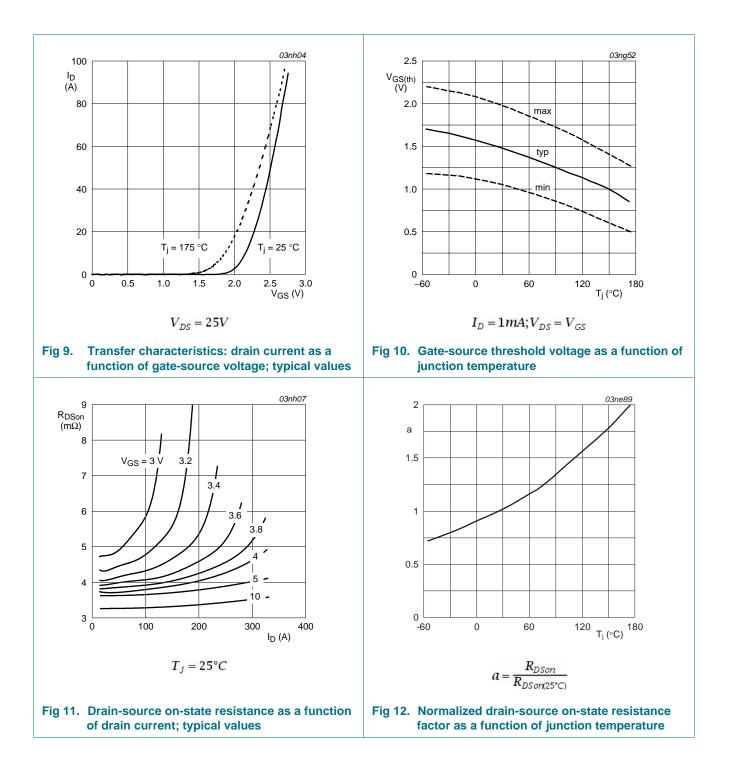


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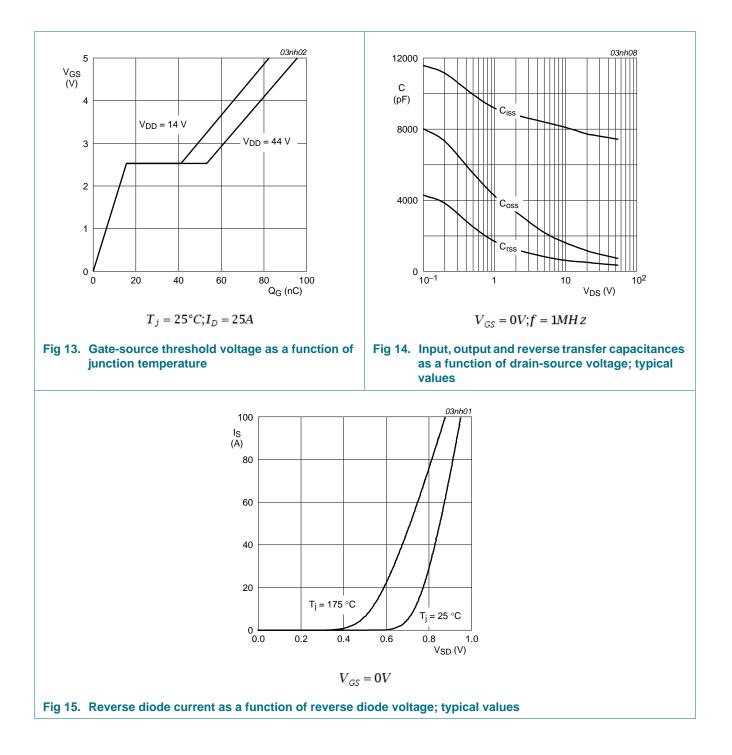
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Package outline 7.

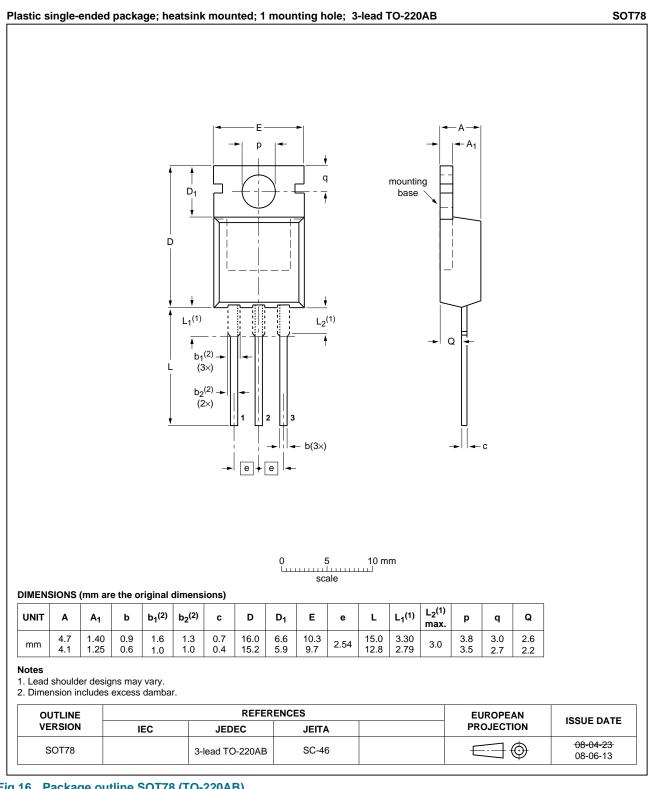


Fig 16. Package outline SOT78 (TO-220AB)

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8. Revision history

Table 7. Revision his	tory						
Document ID	Release date	Data sheet status	Change notice	Supersedes			
BUK954R2-55B v.3	20100608	Product data sheet	-	BUK95_964R2_55B-02			
Modifications:		of this data sheet has been hiconductors.	en redesigned to comply w	vith the new identity guidelines			
	 Legal texts have been adapted to the new company name where appropriate. 						
	 Type number 	er BUK954R2-55B separ	ated from data sheet BUk	(95_964R2_55B-02.			
BUK95_964R2_55B-02 (9397 750 10277)	20021008	Product data	-	-			

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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